

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/662,003	LEE ET AL.	
Examiner	Young J. Kim	Art Unit 1637	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
SEQ ID Numbers 3, 4, and 12 STIC search (commercial, patent, published patent databases) see enclosed results	1/26/2006	YJK
STN commercial Databases (Biosis, Medline, Embase, Embal, Scisearch, CaPlus) see enclosed for text-search strategy	1/26/2006	YJK
Patent Databases (USPT, USPPGP, EPO, JPO, DERWENT, IBM-TDB) see enclosed for text-search strategy	1/26/2006	YJK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner